

Joint ICTP-IAEA Advanced Workshop on High Sensitivity 2D & 3D
Characterisation and Imaging with Ion Beams | (smr 2856)

Contribution ID : 30

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Presentation of the TwinMic beamline

Wednesday, 28 September 2016 16:30 (1:00)

Content

Summary

Presenter(s) : GIANONCELLI, Alessandra (Elettra Sincrotrone Trieste)

Session Classification : DAY 3